

tentative

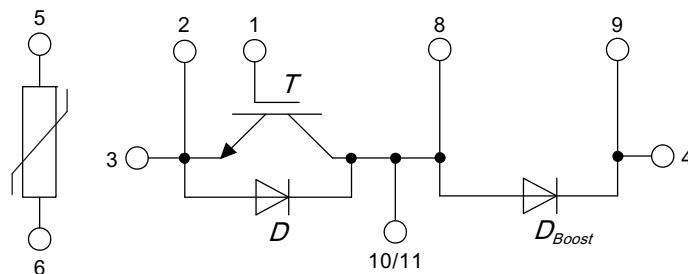
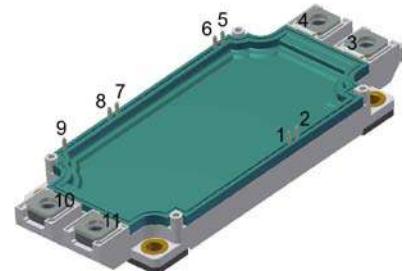
XPT IGBT Module

V_{CES} = **1200 V**
I_{C25} = **360 A**
V_{CE(sat)} = **1.8 V**

Boost chopper + free wheeling Diodes + NTC

Part number

MIXA225RF1200TSF

**Features / Advantages:**

- High level of integration - only one power semiconductor module required for the whole drive
- Rugged XPT design (Xtreme light Punch Through) results in:
 - short circuit rated for 10 μ sec.
 - very low gate charge
 - low EMI
 - square RBSOA @ 3x I_c
- Thin wafer technology combined with the XPT design results in a competitive low $V_{CE(sat)}$
- Temperature sense included
- SONIC™ diode
 - fast and soft reverse recovery
 - low operating forward voltage

Applications:

- Brake for AC motor drives
- Boost chopper
- Switch reluctance drives

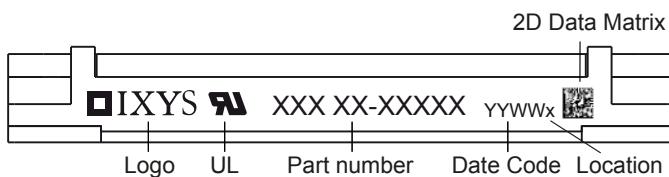
Package: SimBus F

- Industry standard outline
- RoHS compliant
- Soldering pins for PCB mounting
- Height: 17 mm
- Base plate: Copper internally DCB isolated
- Advanced power cycling

IGBT T			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ\text{C}$ to 125°C			1200	V
V_{GES}	max. DC gate voltage				± 20	V
V_{GEM}	max. transient gate emitter voltage				± 30	V
I_{C25}	collector current	$T_C = 25^\circ\text{C}$			360	A
I_{C80}		$T_C = 80^\circ\text{C}$			250	A
P_{tot}	total power dissipation	$T_C = 25^\circ\text{C}$			1100	W
$V_{CE(\text{sat})}$	collector emitter saturation voltage	$I_C = 225 \text{ A}; V_{GE} = 15 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$	1.8	2.1	V
			$T_{VJ} = 125^\circ\text{C}$	2.1		V
$V_{GE(\text{th})}$	gate emitter threshold voltage	$I_C = 9 \text{ mA}; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ\text{C}$	5.4	6.5	V
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$		0.3	mA
			$T_{VJ} = 125^\circ\text{C}$		0.3	mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 \text{ V}; V_{CE} = 0 \text{ V}$			1.5	μA
$Q_{G(\text{on})}$	total gate charge	$V_{CE} = 600 \text{ V}; V_{GE} = 15 \text{ V}; I_C = 225 \text{ A}$			690	nC
$t_{d(\text{on})}$	turn-on delay time	$T_{VJ} = 125^\circ\text{C}$			60	ns
t_r	current rise time				70	ns
$t_{d(\text{off})}$	turn-off delay time				280	ns
t_f	current fall time				310	ns
E_{on}	turn-on energy per pulse				20	mJ
E_{off}	turn-off energy per pulse				27	mJ
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 \text{ V}; R_G = 3.3 \Omega$	$T_{VJ} = 125^\circ\text{C}$			
I_{CM}		$V_{CE\text{max}} = 1200 \text{ V}$			500	A
SCSOA	short circuit safe operating area	$V_{CE\text{max}} = 1200 \text{ V}$	$T_{VJ} = 125^\circ\text{C}$			
t_{sc}	short circuit duration	$V_{CE} = 900 \text{ V}; V_{GE} = \pm 15 \text{ V}; R_G = 3.3 \Omega$; non-repetitive			900	μs
I_{sc}	short circuit current				10	A
R_{thJC}	thermal resistance junction to case				0.115	K/W
R_{thCH}	thermal resistance case to heatsink				0.045	K/W
Diode D_{Boost}						
V_{RRM}	max. repetitive reverse voltage				1200	V
I_{F25}	forward current	$T_C = 25^\circ\text{C}$			265	A
I_{F80}		$T_C = 80^\circ\text{C}$			185	A
V_F	forward voltage	$I_F = 225 \text{ A}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$	1.80	2.10	V
			$T_{VJ} = 125^\circ\text{C}$	1.70		V
I_R	reverse current	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ\text{C}$		0.3	mA
			$T_{VJ} = 125^\circ\text{C}$			mA
Q_{rr}	reverse recovery charge	$T_{VJ} = 125^\circ\text{C}$			32	μC
I_{RM}	max. reverse recovery current				250	A
t_{rr}	reverse recovery time				340	ns
E_{rec}	reverse recovery energy				11.7	mJ
R_{thJC}	thermal resistance junction to case				0.145	K/W
R_{thCH}	thermal resistance case to heatsink				0.05	K/W

Diode D			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$			1200	V
I_{F25}	forward current	$T_C = 25^\circ C$			65	A
I_{F80}		$T_C = 80^\circ C$			45	A
V_F	forward voltage	$I_F = 60 A; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$		2.0	V
			$T_{VJ} = 125^\circ C$		2.0	V
I_R	reverse current * not applicable, see Ices value of IGBT T	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ C$		*	mA
			$T_{VJ} = 125^\circ C$		*	mA
R_{thJC}	thermal resistance junction to case				0.5	K/W
R_{thCH}	thermal resistance case to heatsink				0.2	K/W

Package SimBus F			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
I_{RMS}	RMS current	per terminal				A
T_{stg}	storage temperature		-40		125	°C
T_{VJM}	virtual junction temperature		-40		150	°C
Weight				350		g
		$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			3400	V~
M_D	mounting torque (M5)		3		6	Nm
M_T	terminal torque (M6)		3		6	Nm
$d_{Spp/App}$	creepage distance on surface / striking distance through air	terminal to terminal	12.7			mm
$d_{Spb/Apb}$		terminal to backside	10.0			mm
V_{ISOL}	isolation voltage	$t = 1 \text{ second}$		3000		V
		$t = 1 \text{ minute}$		2500		V
$R_{term-chip}$	resistance terminal to chip	$V = V_{CEsat} + 2x R_{term-chip} \cdot I_C$ resp. $V = V_F + 2x R \cdot I_F$		0.65		$\text{m}\Omega$

**Part number**

M = Module
I = IGBT
X = XPT
A = standard
225 = Current Rating [A]
RF = Boost / brake chopper + free wheeling diode
1200 = Reverse Voltage [V]
T = NTC
EH = E3-Pack

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXA225RF1200TSF	MIXA225RF1200TSF	Box	3	511581

Temperature Sensor NTC			Ratings			
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	resistance	$T_C = 25^\circ C$	4.75	5.0	5.25	kΩ
$B_{25/50}$	temperature coefficient			3375		K

Outlines SimBus F

